PCN Number: 202			2041	13002.1		PC	N Da	ate: April 14, 2022		
Title: Qualification of new Fab site (RFAB) using qualified Process Technology, Die Republication Datasheet update and additional Assembly site/BOM options for select devices										
Custo	omer Contact:		PC	<u>N Manager</u>		De	pt: Quality Services		Quality Services	
Proposed 1 st Ship Date:			Jul	14, 2022	Estimated Sample Availability:Date provided at sample request.					
Change Type:										
A	ssembly Site		Assembly Process				🛛 🖾 Assen		mbly Materials	
	Design		Electrical Specification		ation			Mechanical Specification		
	est Site			Packing/Shipping/	Labeling		Test Proce		Process	
V	Vafer Bump Site 🛛 🗌 Wafer Bump Mate		rial			Wafe	r Bump Process			
V 🛛	Vafer Fab Site		Wafer Fab Materials		ıls		\boxtimes	Wafe	r Fab Process	
				Part number chan	ge			-		
	PCN Details									

Description of Change:

Texas Instruments is pleased to announce the qualification of a new fab & process technology (RFAB, LBC7) and assembly (HFTF) site/BOM options for selected devices as listed below in the product affected section.

Current Fab Site			New Fab Site			
Fab Site	ab Site Process Wafer Diameter		Fab Site Process Wafer Diamete			
DL-LIN	C21	150 mm			200 mm	
DL-LIN	C21	200 mm	RFAB	LBC7	300 mm	

The die was also changed as a result of the process change.

Construction Differences (Group 1 devices only):

	ASESH	HFTF
Bond wire Composition, diameter	Cu, 1.0 mil	Cu, 0.8 mils
Mold Compound	SID#EN2000763	SID#R-30
Mount Compound	SID#EY1000063	SID#A-18

Devices listed in Group 2 will have no Assembly site or BOM changes.

The datasheets will be changing as a result of the above mentioned changes. The datasheet change details can be reviewed in the datasheet revision history. The link to the revised datasheet is available in the table below.



PCA9536 SCPS125H – APRIL 2006 – REVISED MARCH 2022

Ch	anges from Revision G (June 2014) to Revision H (March 2022)	Page
•	Changed all instances of legacy terminology to controller and target where I2C is mentioned	1
	Deleted the DSBGA (YZP) package information	
•	Added the Simplified Schematic to the front page	1
	Removed packaging information from the Absolute Maximum Ratings table	
•	Added T _{sta} to the Absolute Maximum Ratings table	4
•	Added T _{stg} to the Absolute Maximum Ratings table Added the Thermal Information table	4
	Deleted VPOR from the Electrical Characteristics	
	Added V _{PORR} and V _{PORF} to the Electrical Characteristics	
	Changed the I _{CC} stand by mode current max values for 5.5 V from 1 to 1.8 µA; 3.6 V from 0.9 to 1.2 µ	
	2.7 V from 0.8 to 1 µA in the Electrical Characteristics	5
•	Changed the $t_{vd(ack)}$ and $t_{vd(ack)}$ MAX values from: 1 µs to: 3.45 µs in the Standard Mode timing	6
•	Changed the t _{icr} , t _{ocf} , and t _{ocf} MIN values in the <i>Fast Mode</i> timing	<mark>6</mark>
•	Changed the t _{icr} , t _{ocf} , and t _{ocf} MIN values in the <i>Fast Mode</i> timing Added the Overview section	12
	Added the Device Functional Modes section	
•	Added Detailed Design Procedure section	20
•	Added Application Curves section	21
	Added the Layout section	

Product Folder	Current Datasheet Number	New Datasheet Number	Link to full datasheet
PCA9536	SCPS125G	SCPS125H	http://www.ti.com/product/PCA9536

Tube versions of the devices are included in EOL notice PDN# 20220413003.3.

Qual details are provided in the Qual Data Section.

Reason for Change:

These changes are part of our multiyear plan to transition products from our 150-milimeter factories to newer, more efficient manufacturing processes and technologies, underscoring our commitment to product longevity and supply continuity.

Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):

None

Impact on Environmental Ratings:

Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.

RoHS	REACH	Green Status	IEC 62474
🛛 No Change	🛛 No Change	🛛 No Change	🛛 No Change

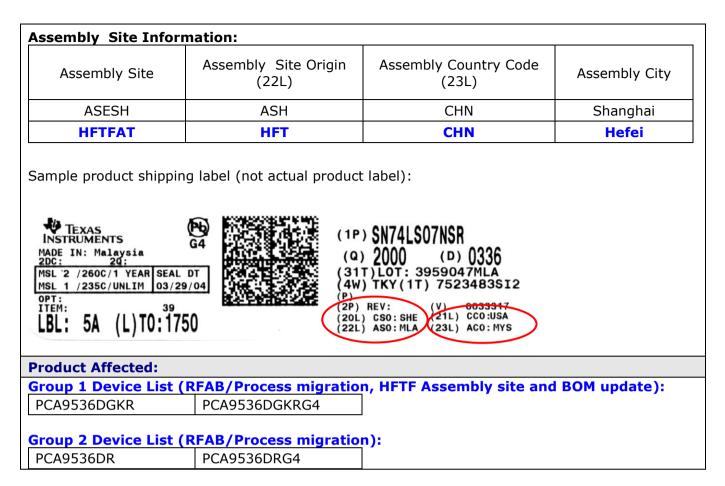
Changes to product identification resulting from this PCN:

Fab Site Information:

Chip Site	Chip Site Origin Code (20L)	Chip Site Country Code (21L)	Chip Site City
DL-LIN	DLN	USA	Dallas
RFAB	RFB	USA	Richardson

Die Rev:

Current	New
Die Rev [2P]	Die Rev [2P]
-	Α



Qualification Report

Approve Date 13-Jan-2022

Туре	Test Name / Condition	Duration	Qual Device: <u>TCA9537DGS</u>	QBS Process Reference: TPS51217DSC	QBS Package Reference: <u>LM5008MM</u>	QBS Package Reference: <u>TPS62842DGR</u>
AC	Autoclave 121C	96 Hours	-	3/231/0	-	3/231/0
CDM	ESD - CDM	1500 V	1/3/0	-	-	-
ED	Electrical Characterization	Per Datasheet Parameters	1/30/0	3/60/0	-	-
HAST	Biased HAST 130C/85%RH	96 Hours	-	3/231/0	3/231/0	3/231/0
HBM	ESD - HBM	3000 V (All pins)	1/3/0	-	-	-
HBM	ESD - HBM	4000 V (pins 1-4, 7, 10)	1/3/0	-	-	-
HTOL	Life Test, 135C	635 Hours	-	3/231/0	-	-
HTOL	Life Test, 150C	300 Hours	-	-	-	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	3/231/0	3/231/0	3/231/0
LU	Latch-up	(Per JESD78)	1/6/0	-	-	-
TC	Temperature Cycle -65/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0
UHAST	Unbiased HAST, 130C/85%RH	96 Hours	-	-	3/231/0	-
WBP	Bond Pull	wires	1/76/0	-	3/228/0	-
WBS	Ball Bond Shear	wires	1/76/0	-	-	-

Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed

- QBS: Qual By Similarity

- Qual Device TCA9537DGS is qualified at LEVEL1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours - The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free (SMT) and Green

Qualification Report

Approve Date 29-Nov-2021

	Data Displayed as: Number of lots / Total sample size / Total failed						
Туре	Test Name / Condition	Duration	Qual Device: <u>PCA9536DGK</u>	QBS Process Reference: <u>TPS51217DSC</u>	QBS Package Reference: <u>LM5008MM</u>	QBS Package Reference: <u>TP S62842DGR</u>	
AC	Autoclave 121C	96 Hours	1/77/0	3/231/0	-	3/231/0	
CDM	ESD - CDM	1500 V	1/3/0	-	-	-	
ED	Electrical Characterization	Per Datasheet Parameters	Pass	-	-	-	
HAST	Biased HAST 130C/85%RH	96 Hours	-	3/231/0	3/231/0	3/231/0	
HBM	ESD – HBM (All Pins)	3000 V	1/3/0	-	-	-	
нвм	ESD – HBM (Pins 1,2,3,5,8)	4000 V	1/3/0	-	-	-	
HTOL	Life Test, 135C	635 Hours	-	3/231/0	-	-	
HTOL	Life Test, 150C	300 Hours	-	-	-	3/231/0	
HTSL	High Temp Storage Bake, 170C	420 Hours	1/77/0	3/231/0	3/231/0	3/231/0	
LU	Latch-up	(Per JESD78)	1/6/0	-	-	-	
тс	Temperature Cycle, - 65/150C	500 Cycles	1/77/0	3/231/0	3/231/0	3/231/0	
UHAST	Unbiased HAST, 130C/85%RH	96 Hours	-	-	3/231/0	-	
WBP	Bond Pull	Wires	1/76/0	-	-	-	
WBS	Ball Bond Shear	Wires	1/76/0	-	-	-	

Qualification Results

QBS: Qual By Similarity

- Qual Device PCA9536DGK is gualified at LEVEL1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free (SMT) and Green

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

Location	E-Mail
WW Change Management Team	PCN ww admin team@list.ti.com

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